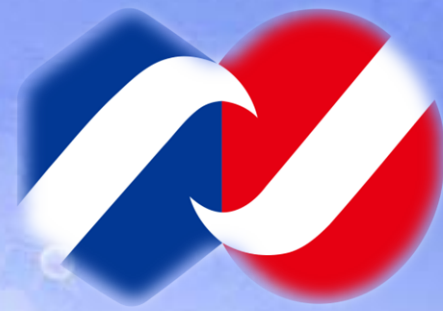


**Bulk GaN based violet light-emitting diodes  
with high efficiency at very high current density**

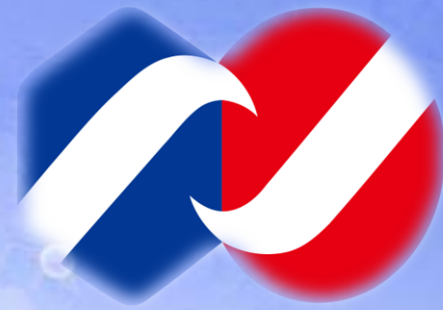
**student : JIANG JHIH YIN**

**advising professor : LIN JHENG FONG**



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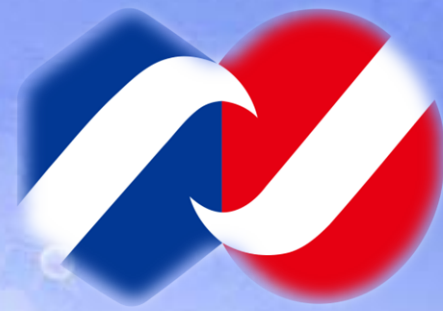
**key technology**

**high-efficiency light sources**



**high external quantum efficiency**

**high current densities**



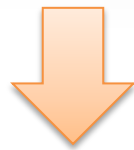
**commercial LEDs**



**due to the lack of availability of a native substrate**

**internal quantum efficiency**

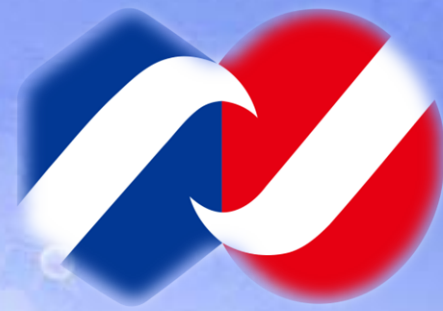
**efficient light extraction**



**detrimental**

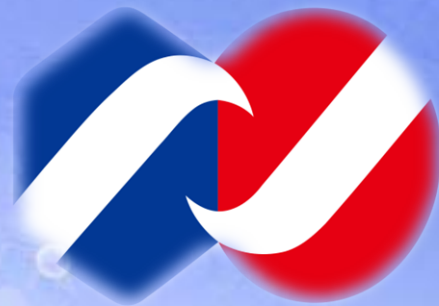


**advanced schemes**

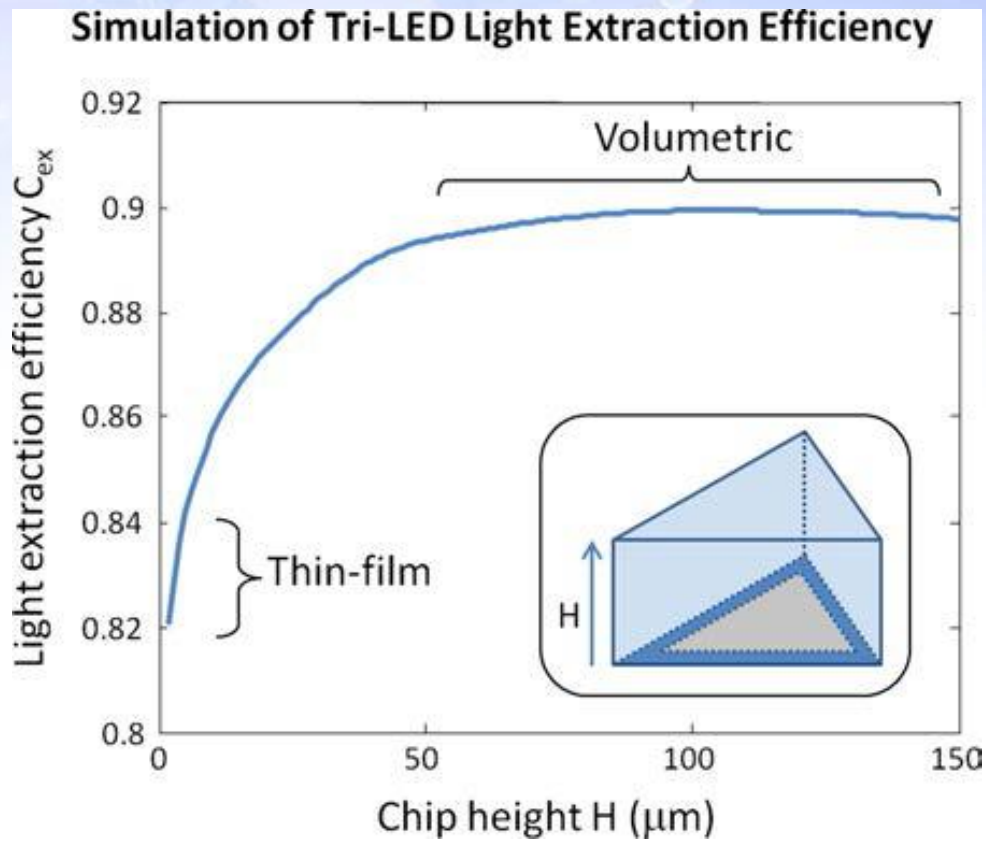
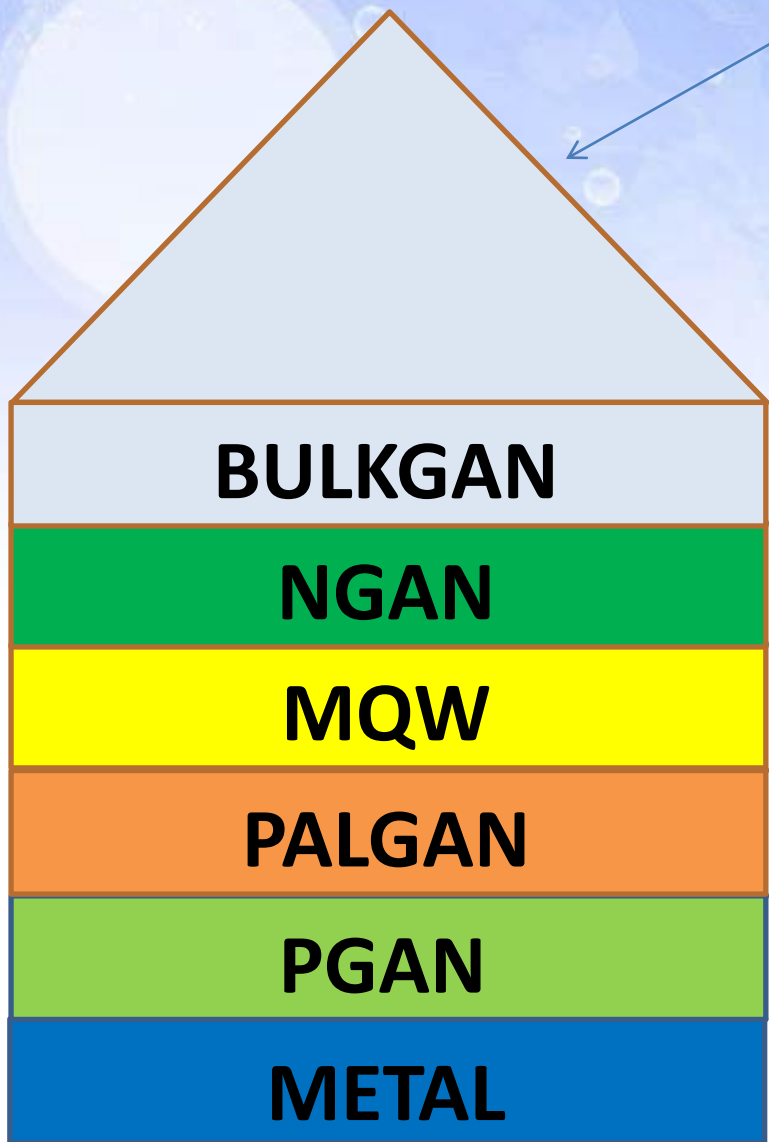


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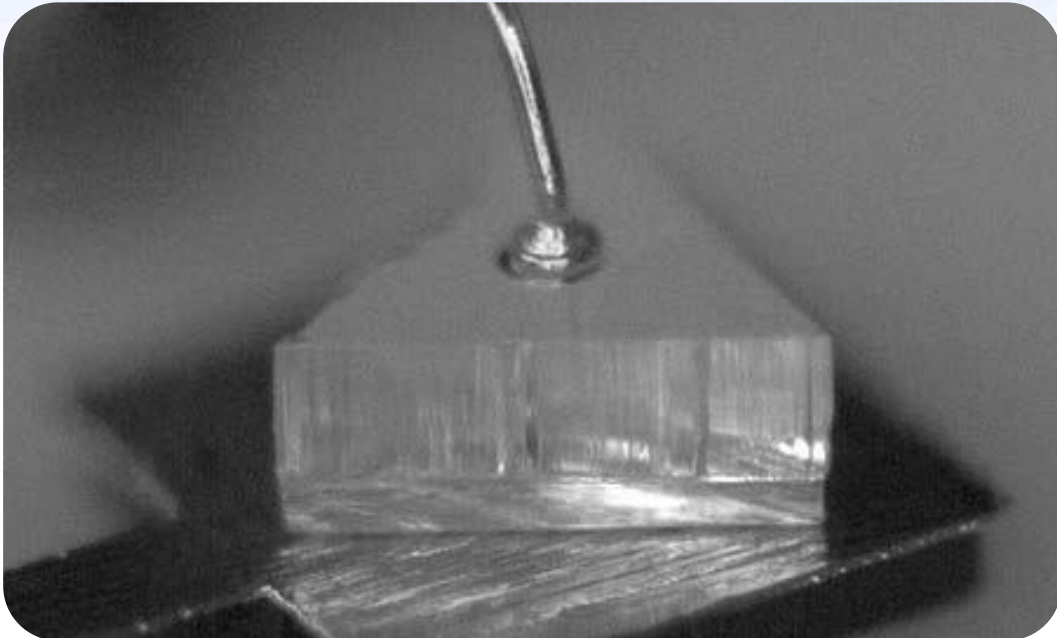
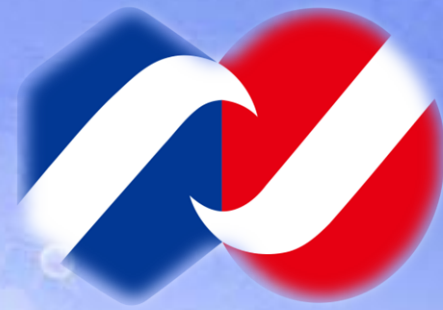


380 $\mu$ m

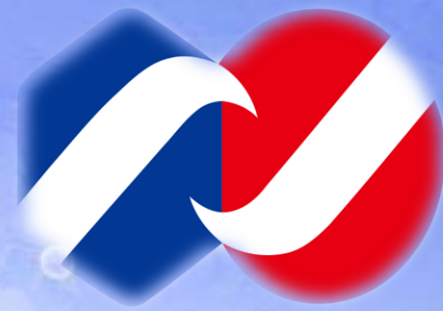


- The chip has an equilateral triangular base and a roughened top surface.

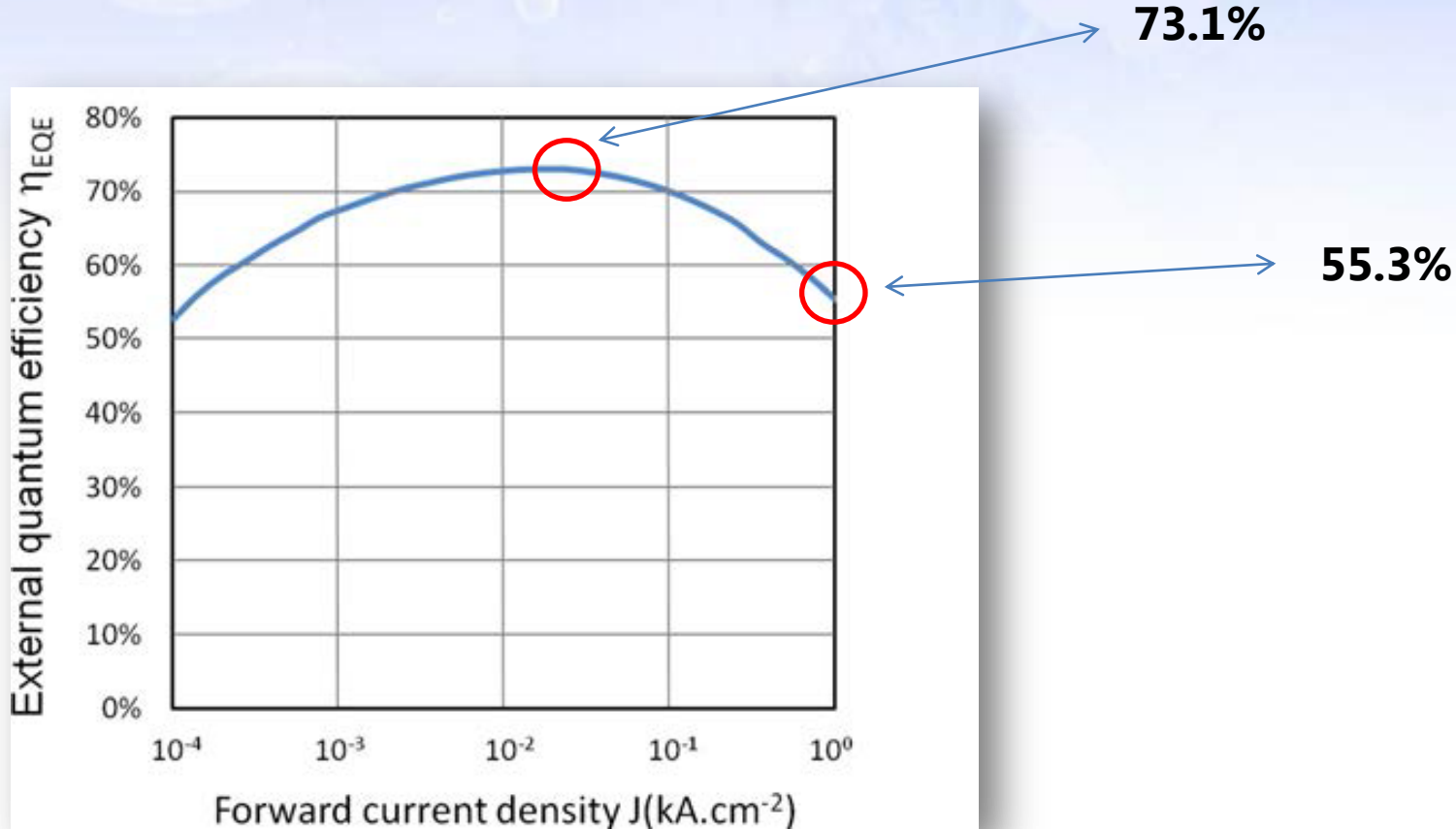
- taking care to minimize optical losses in the chip in order to improve Cex





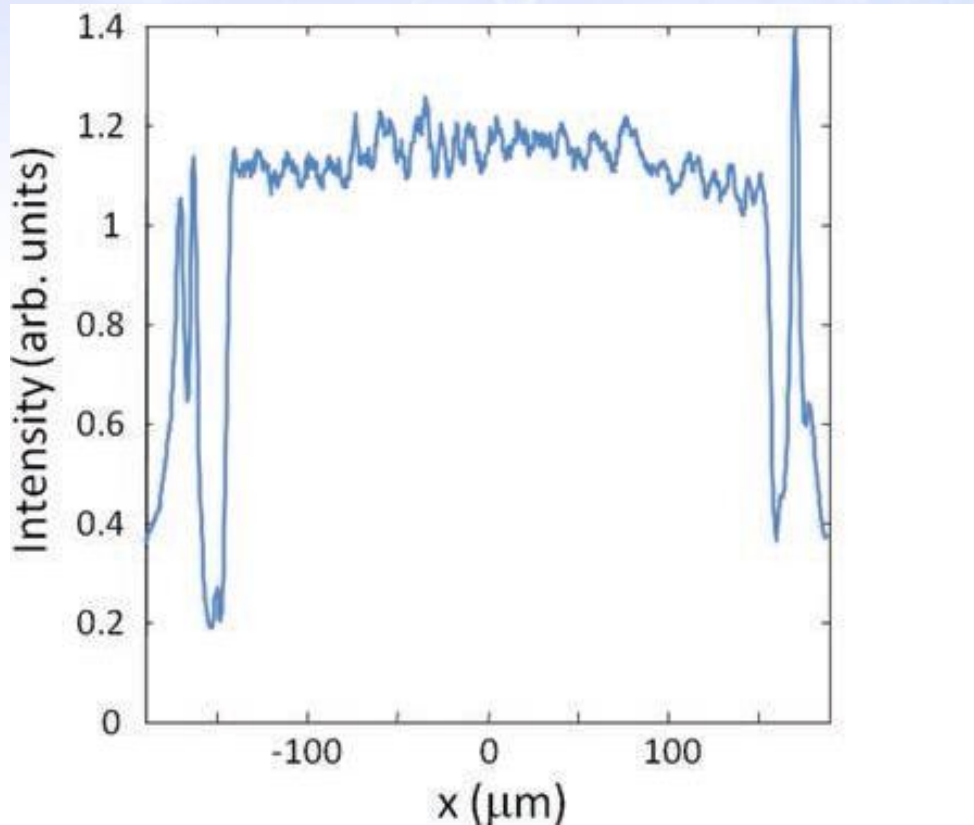
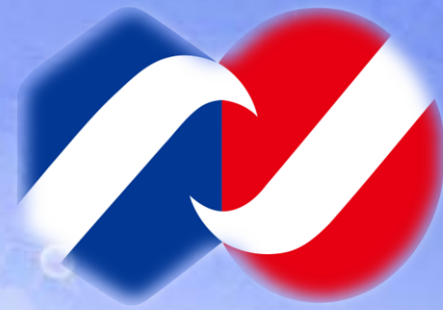


- External quantum efficiency versus  $J$  shown in logarithmic scale, to clarify the device's behavior around  $J_{pea}$



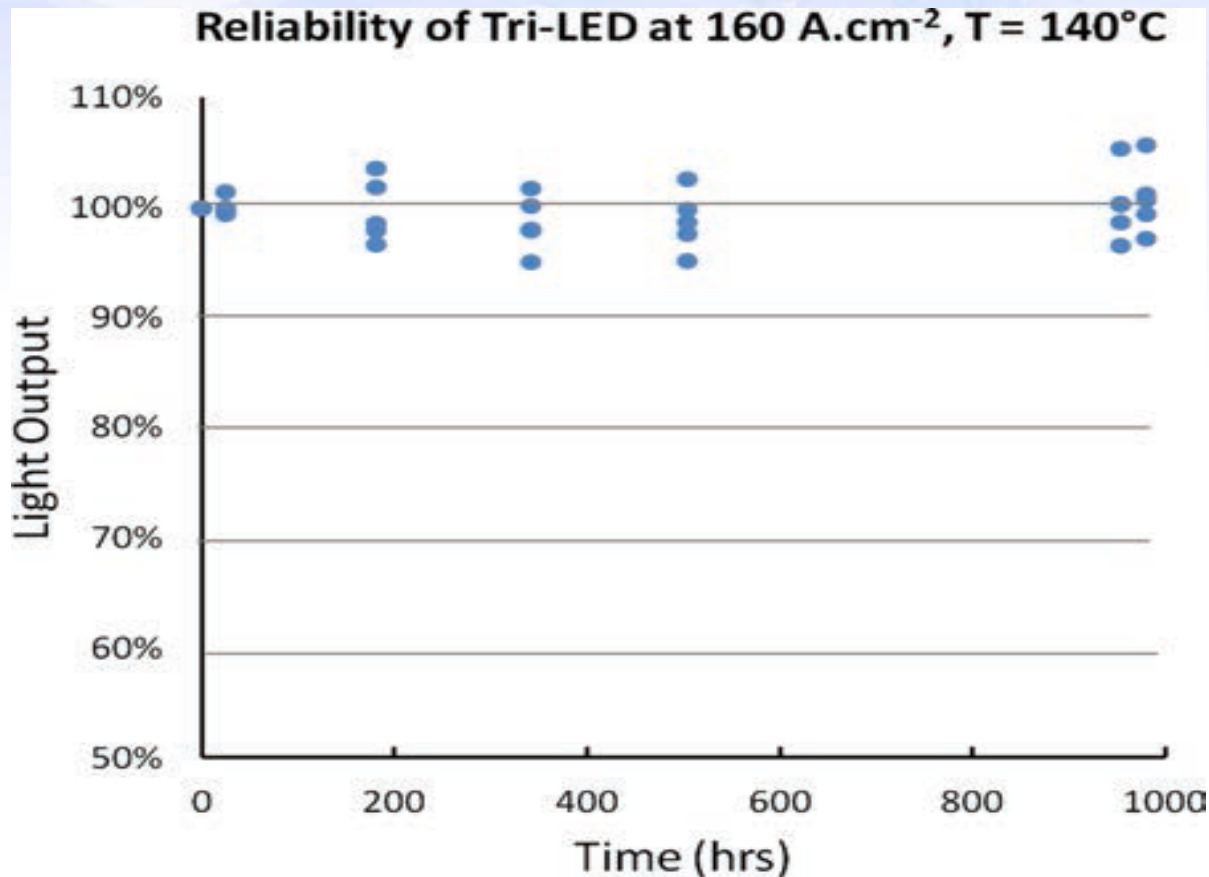
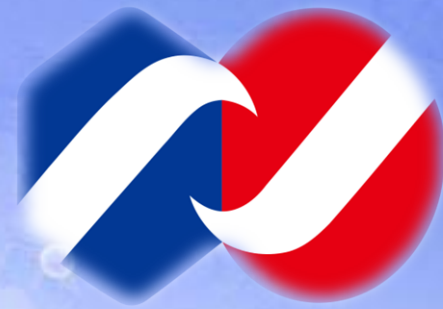


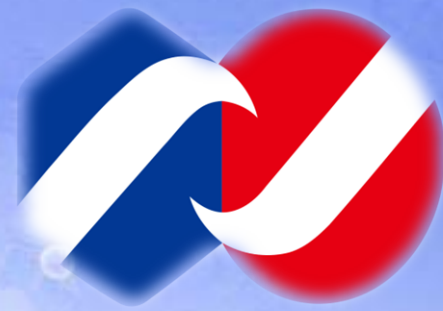
- **Microscope image of the active region of a Tri-LED under operation at 500Acm<sup>-2</sup>, evidencing the absence of current crowding**
- **The light output is uniform within 6.5% at this very high current density, as confirmed in the cross-section intensity profile.**



- **Stability of light output under stress conditions ( $J \frac{1}{4} 160 \text{ Acm}^2$  and  $T \frac{1}{4} 140 \text{ C}$ ).**

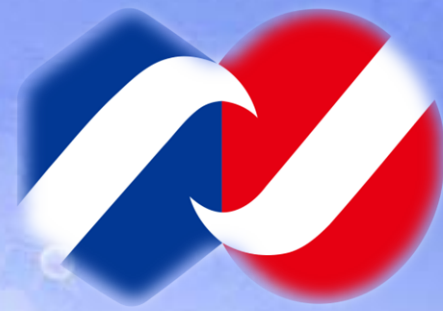
- **Each point represents a device. No degradation is observed over 1000 h.**





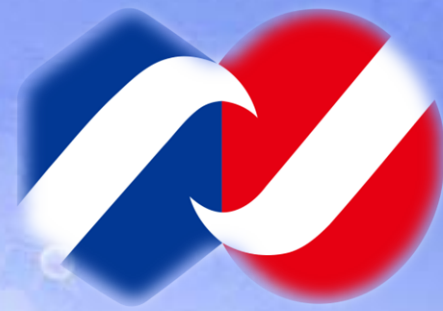
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- **we have demonstrated LEDs grown on bulk GaN substrates, which exhibit very high external quantum efficiency at high current density**
- **We have also confirmed the absence of current crowding at high current density in our devices, and demonstrated their reliability under high-current**
- **this technological breakthrough is expected to enable a generation of solid-state lighting systems based on higher power density LEDs providing a fundamental shift towards dramatically improved cost per optical Watt.**

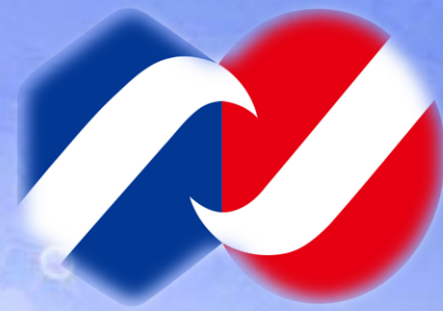




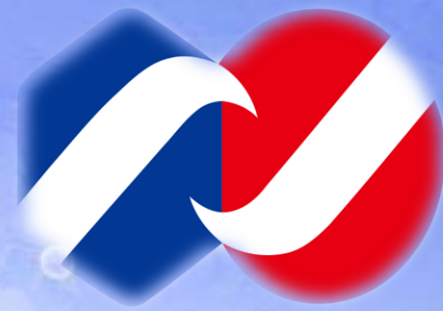
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**Thanks for your attention**